

Certified Reference Material

Certificate of Analysis

Product ID: IARM-Cu954-20

ISO
17034:2016

ISO/IEC
17025:2017

ISO
9001:2015

Product Description: Aluminum Bronze, CDA 954 / UNS C95400

Revision No.: 000
Revision Date: 04/06/2022

Description and Intended Use: This **Certified Reference Material** is covered under the scope of accreditation to **ISO 17034** by LGC Standards - Manchester, NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in **ISO 17025** accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods.

Certified Values listed in wt.% with associated uncertainties

Ag 0.0015 ± 0.0003	Al 10.48 ± 0.09	As 0.0007 ± 0.0003	Bi 0.0012 ± 0.0004
Co 0.0012 ± 0.0002	Cr 0.028 ± 0.002	Cu 84.7 ± 0.4	Fe 3.84 ± 0.03
Mn 0.54 ± 0.01	Ni 0.30 ± 0.01	P 0.009 ± 0.001	Pb 0.018 ± 0.002
S 0.005 ± 0.002	Sb 0.0018 ± 0.0006	Si 0.029 ± 0.002	Sn 0.010 ± 0.001
Zn 0.068 ± 0.005			

Indicative Values listed in ppm

Be (1)	C (80)	Ca (10)	Cd (1)	Mg (100)	O (6)	Se (7)
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Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where N_{prod} is the number of units produced and N_{min} is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculate uncertainty due to inhomogeneity (U_{hom}). Uncertainty of the material is calculated by equation 2, where $H=U_{hom}$, S = Standard deviation, t = t-value at 95% CI, and n = number of observations.

$$1. N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$

$$2. U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognized reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- LGC Standards - Manchester, NH
- Lucid Laboratories - Telangana, India
- IMR Test Labs - Lansing, NY
- TCR Engineering Services - Mumbai, India
- NSL Analytical Services - Cleveland, OH
- SGS MSI - Melrose Park, IL
- AnchorCert Analytical - Birmingham, UK
- EAG Laboratories - Liverpool, NY
- Lithea s.r.o. - Brno, Czech Republic
- New Hampshire Materials Laboratory - Somersworth, NH
- Scrooby's Laboratory Services - Benoni, South Africa
- Universal Scientific Laboratory - Revesby, Australia
- IMR Test Labs - Louisville, KY
- Connecticut Metallurgical, Inc. - East Hartford, CT

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use.

Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.


Kimberly Halkotis, Global Product Manager

April 6, 2022
Certification Date



ISO 17034 Accredited: Reference Materials
Producer, Certificate # 2848.02
ISO/IEC 17025 Accredited: Chemical
Testing, Certificate # 2848.01

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.



The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	Al	As	Be	Bi	C	Ca	Cd	Co	Cr	Cu	Fe	Mg
1	0.0004	10.270	0.0003	0.0001	0.0002	0.0032	0.0010	0.0001	0.0008	0.0240	83.880	3.7285	0.0005
2	0.0010	10.310	0.0004	0.0001	0.0005	0.0046	<0.0001	<0.0001	0.0010	0.0248	84.520	3.7382	0.0006
3	0.0010	10.368	0.0004		0.0010	0.0062		<0.001	0.0010	0.0250	84.540	3.7700	0.0006
4	0.0011	10.370	0.0005		0.0010	0.0065			0.0010	0.0250	84.650	3.7710	0.0007
5	0.0012	10.375	0.0006		0.0010	0.0080			0.0011	0.0252	84.700	3.8009	0.0008
6	0.0013	10.400	0.0010		0.0012	0.0100			0.0011	0.0260	84.830	3.8190	0.0008
7	0.0015	10.440	0.0010		0.0013	0.0111			0.0012	0.0263	85.180	3.8430	0.0012
8	0.0017	10.450	0.0010		0.0014	0.0120			0.0014	0.0265	85.250	3.8570	0.0145
9	0.0017	10.450	0.0011		0.0014	<0.005			0.0015	0.0272		3.8600	0.0172
10	0.0018	10.517	<0.001		0.0020				0.0018	0.0273		3.8600	0.0206
11	0.0019	10.521	<0.001		0.0026				<0.002	0.0276		3.8602	0.0280
12	0.0020	10.522	<0.002		<0.0001				<0.002	0.0276		3.8900	0.0296
13	0.0021	10.530	<0.002		<0.0010				<0.002	0.0310		3.9020	<0.001
14	0.0025	10.539	<0.002		<0.002				<0.0020	0.0310		3.9100	<0.0010
15	<0.002	10.558	<0.005		<0.002					0.0320		3.9180	<0.005
16	<0.005	10.760	<0.0050		<0.002					0.0320		3.9200	
17		10.760			<0.005					0.0322			
18										0.0333			
Mean	0.0015	10.479	0.0007	0.0001	0.0012	0.0077	0.0010	0.0001	0.0012	0.0280	84.694	3.8405	0.0096
STDV	0.0006	0.1351	0.0003	0.0000	0.0006	0.0031			0.0003	0.0031	0.4280	0.0631	0.0116
Certified	0.0015	10.48	0.0007	(0.0001)	0.0012	(0.008)	(0.001)	(0.0001)	0.0012	0.028	84.7	3.84	(0.01)
U _{CRM}	0.0003	0.09	0.0003		0.0004				0.0002	0.002	0.4	0.03	
Methods	I,IM,O,G,X	I,O,G,X,W	I,IM,O,X	I,O	I,IM,O,X	C,G	I	I,O	I,IM,O,X,A	I,IM,O,G,X	I,O,X,W	I,O,G,X	I,IM,O,G,X

	Mn	Ni	O	P	Pb	S	Sb	Se	Si	Sn	Zn
1	0.4910	0.2605	0.0006	0.0060	0.0122	0.0013	0.0008	0.0001	0.0220	0.0058	0.0520
2	0.4950	0.2630	<0.0005	0.0060	0.0143	0.0039	0.0010	0.0003	0.0246	0.0070	0.0560
3	0.5210	0.2710		0.0069	0.0153	0.0049	0.0010	0.0006	0.0255	0.0075	0.0644
4	0.5220	0.2890		0.0070	0.0160	0.0060	0.0012	0.0010	0.0270	0.0080	0.0646
5	0.5370	0.2980		0.0075	0.0164	0.0060	0.0015	0.0010	0.0280	0.0080	0.0648
6	0.5374	0.3000		0.0077	0.0170	0.0070	0.0015	0.0012	0.0280	0.0090	0.0650
7	0.5378	0.3005		0.0080	0.0170	0.0080	0.0021	<0.00005	0.0280	0.0090	0.0650
8	0.5400	0.3023		0.0086	0.0177	<0.0001	0.0025	<0.001	0.0280	0.0090	0.0650
9	0.5435	0.3034		0.0086	0.0185	<0.0005	0.0030	<0.005	0.0288	0.0091	0.0660
10	0.5462	0.3050		0.0090	0.0189	<0.001	0.0033	<0.0050	0.0290	0.0099	0.0690
11	0.5470	0.3070		0.0093	0.0189	<0.0010	<0.0010		0.0290	0.0103	0.0693
12	0.5490	0.3090		0.0100	0.0190	<0.005	<0.005		0.0297	0.0108	0.0700
13	0.5510	0.3156		0.0100	0.0190	<0.005	<0.005		0.0300	0.0121	0.0724
14	0.5530	0.3220		0.0100	0.0200		<0.005		0.0303	0.0130	0.0731
15	0.5540	0.3280		0.0111	0.0200		<0.005		0.0312	0.0142	0.0811
16	0.5670	0.3280		0.0117	0.0203				0.0314	0.0150	0.0840
17	0.5730	0.3300		0.0120	0.0252				0.0320	0.0150	
18	0.5800	0.3349							0.0334	<0.005	
Mean	0.5414	0.3037	0.0006	0.0088	0.0180	0.0053	0.0018	0.0007	0.0287	0.0102	0.0676
STDV	0.0232	0.0220		0.0018	0.0029	0.0022	0.0009	0.0004	0.0028	0.0028	0.0079
Certified	0.54	0.30	(0.0006)	0.009	0.018	0.005	0.0018	(0.0007)	0.029	0.010	0.068
U _{CRM}	0.01	0.01		0.001	0.002	0.002	0.0006		0.002	0.001	0.005
Methods	I,G,O,X	I,G,IM,O,X,A	F	I,IM,O,X,W	I,IM,O,X,A	I,C,G,X	I,IM,O,X	I,IM,G	I,IM,O,G,X,W	I,IM,O,X	I,IM,O,A,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES